

Notice of References Cited	Application/Control No. 10/574,610		Applicant(s)/Patent Under Reexamination DERUIJTER, MICHEL JAN	
	Examiner Lorna M. Douyon		Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,867,316	02-1975	Frank et al.	510/537
*	B	US-5,486,317	01-1996	Dorset et al.	510/444
*	C	US-6,017,873	01-2000	Sikra et al.	510/444
*	D	US-6,093,690	07-2000	Chapman, Benjamin Edgar	510/444
*	E	US-6,133,223	10-2000	Sampaio et al.	510/444
*	F	US-6,258,773	07-2001	Mort et al.	510/444
*	G	US-6,288,016	09-2001	Ramanan et al.	510/357
*	H	US-6,514,930	02-2003	Emery et al.	510/444
*	I	US-6,794,354	09-2004	Mort et al.	510/444
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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